

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/630,427 NOBLE, WENDELL P.	
		Examiner	Art Unit Laura M. Schillinger	2813 Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0000757 A1	05-2001	Noble, Wendell P.	438/151
*	B	US-2001/0019870 A1	09-2001	Noble, Wendell P.	438/294
*	C	US-2001/0046728 A1	11-2001	NOBLE, WENDELL P.	438/149
*	D	US-2002/0001885 A1	01-2002	Noble, Wendell P.	438/149
*	E	US-2002/0048921 A1	04-2002	Noble, Wendell P.	438/597
*	F	US-2002/0086466 A1	07-2002	Noble, Wendell P.	438/149
*	G	US-2002/0142519 A1	10-2002	Coronel et al.	438/118
*	H	US-2002/0197848 A1	12-2002	Noble, Wendell P.	438/622
*	I	US-2003/0073268 A1	04-2003	Noble, Wendell P.	438/164
*	J	US-2003/0073296 A1	04-2003	Noble, Wendell P.	438/586
*	K	US-2003/0073306 A1	04-2003	Noble, Wendell P.	438/672
*	L	US-6,689,655 B2	02-2004	Coronel et al.	438/238
*	M	US-2006/0081991 A1	04-2006	Seta, Shoji	257/758

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/630,427	NOBLE, WENDELL P.	
Examiner			Art Unit		Page 2 of 3
Laura M. Schillinger			2813		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,847,454 A	12-1998	Shaw et al.	257/734
*	B	US-5,895,952 A	04-1999	Darwish et al.	257/330
*	C	US-6,008,520 A	12-1999	Darwish et al.	257/330
*	D	US-6,202,191 B1	03-2001	Filippi et al.	716/5
*	E	US-6,344,399 B1	02-2002	Noble, Wendell P.	438/361
*	F	US-6,373,138 B1	04-2002	Noble, Wendell P.	257/773
*	G	US-6,569,779 B1	05-2003	Lundstrom et al.	438/745
*	H	US-2003/0132480 A1	07-2003	Chau et al.	257/332
*	I	US-2004/0018671 A1	01-2004	Noble, Wendell P.	438/151
*	J	US-2005/0056901 A1	03-2005	Kuriyama, Toshihiro	257/428
*	K	US-2005/0124140 A1	06-2005	Mulligan, Rose	438/460
*	L	US-2006/0030142 A1	02-2006	Grebs et al.	438/618
*	M	US-7,078,296 B2	07-2006	Chau et al.	438/270

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/630,427	NOBLE, WENDELL P.	
Examiner		Art Unit		Page 3 of 3
Laura M. Schillinger		2813		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,309,716 A	01-1982	El-Kareh, Badih	257/511
*	B	US-4,476,623 A	10-1984	El-Kareh, Badih	438/324
*	C	US-4,879,251 A	11-1989	Kruehler et al.	438/80
*	D	US-5,572,042 A	11-1996	Thomas et al.	257/10
*	E	US-5,674,766 A	10-1997	Darwish et al.	438/270
*	F	US-5,688,725 A	11-1997	Darwish et al.	438/270
*	G	US-5,713,774 A	02-1998	Thomas et al.	445/23
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.